This short version of MicroNews has been put together to inform you of MAS events at the Microscopy and Microanalysis 2011 meeting in Nashville, August 7-11. Look for a more complete MicroNews after the meeting...Heather Lowers, Editor.

A photo essay (see following page) submitted MAS Past President Ed Vicenzi captures a few moments of the successful triennial International Union of Microbeam Analysis Societies meeting held in Seoul, Korea this spring.*

Clockwise from upper left ...
1. MAS past president Ed Vicenzi announces that MAS' proposal to host IUMAS-6 at M&M in 2014 was approved by the IUMAS council.
2. MAS student scholars Jai Ganesh (second from left) and Julia Mundy (fourth from left) dinner with international student award winners.
3. Julia Mundy delivers the first of two presentations.
4. MAS Computer Activities Chair Nicholas Ritchie describes how tall the international standard beer glass should be.
5. and 6) The amazing Samsung Dance and Drum Troupe entertain IUMAS and ALC attendees at the banquet.
7. MSA President Nestor Zaluzec ponders electron spectroscopy (and other items) during the final session of the meeting.
8. IUMAS president and MAS member Brendan Griffin rarely let go of his Apple laptop.
*Images courtesy of the meeting General Secretary Dr. Se Ahn Song and the meeting photographers.
MAS Council Meeting Preliminary Agenda  
Sunday, August 7, Renaissance Nashville Hotel Fisk Room

The MAS Council meeting is open to all members who wish to observe the discussion. Please drop by if there is a topic you are particularly interested in. This agenda is provided for informational purposes only. As much as possible, Council attempts to stay on track.

<table>
<thead>
<tr>
<th>Time</th>
<th>Activity</th>
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<tbody>
<tr>
<td>07:30</td>
<td>Breakfast</td>
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<tr>
<td>08:00</td>
<td>Call to Order</td>
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<tr>
<td>08:00</td>
<td>Approve agenda (Scott)</td>
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<tr>
<td>08:05</td>
<td>Welcome and Introductions (Scott)</td>
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<tr>
<td>08:10</td>
<td>Acting Secretary’s Report and review of open Action Items (Lowers)</td>
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<tr>
<td>08:30</td>
<td>Treasurer’s Report (Davis)</td>
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<tr>
<td>08:45</td>
<td>Education Committee Report (Musselman)</td>
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<tr>
<td>09:00</td>
<td>Membership Services Report (Kremser)</td>
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<tr>
<td>09:15</td>
<td>Nominating Committee Report (Mansfield)</td>
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<tr>
<td>09:25</td>
<td>Vote on Council election nominees (Scott)</td>
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<tr>
<td>09:30</td>
<td>Break</td>
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<tr>
<td>10:00</td>
<td>Strategic Planning Committee Report (Anderson)</td>
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<td></td>
<td>Awards Committee discussion, M&amp;M 2011 Awards Action items</td>
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<td></td>
<td>Council restructuring status</td>
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<td></td>
<td>new MAS logo discussion</td>
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<td></td>
<td>MSA-MAS relations</td>
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<td>11:00</td>
<td>Topical Conferences Report (Carpenter)</td>
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<td></td>
<td>Cathodoluminescence 2011</td>
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<td></td>
<td>ESSD 2011</td>
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<td></td>
<td>Reference Materials 2012</td>
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<td></td>
<td>future TCs</td>
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<tr>
<td>11:40</td>
<td>Meetings</td>
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<tr>
<td></td>
<td>M&amp;M 2011 Nashville (Watanabe)</td>
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<td></td>
<td>M&amp;M 2012 Phoenix (Smentkowski)</td>
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<td></td>
<td>M&amp;M 2013 Indianapolis (Marquis)</td>
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<td></td>
<td>M&amp;M 2014 Hartford (TBD)</td>
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<tr>
<td>12:00</td>
<td>Lunch</td>
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<tr>
<td>01:00</td>
<td>International Liaison Report (Vicenzi)</td>
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<td></td>
<td>IUMAS 5 Seoul (Vicenzi/Giffin)</td>
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<td></td>
<td>IUMAS 6 Hartford (Vicenzi)</td>
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<tr>
<td>01:20</td>
<td>Computer Activities Report (Ritchie)</td>
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<tr>
<td>01:35</td>
<td>ARE5 Report (Hlava/Woodward)</td>
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<tr>
<td>01:50</td>
<td>AMAS partnership and news from Australia (Netting)</td>
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<tr>
<td>02:00</td>
<td>Finance Committee and Schwab act discussion (Kelly)</td>
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<tr>
<td>02:30</td>
<td>Sustaining Members Report (Giamuza)</td>
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<tr>
<td>02:45</td>
<td>MicroNews Report (Lowers)</td>
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<tr>
<td>03:00</td>
<td>Archivist Report (Fournelle)</td>
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<tr>
<td>03:15</td>
<td>Corporate Liaison Report (Robertson)</td>
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<tr>
<td>03:30</td>
<td>Microscopy Today (Lyman)</td>
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<tr>
<td>03:45</td>
<td>Other Business (Scott)</td>
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<tr>
<td>04:45</td>
<td>Review new action items, set WC date? (Mansfield)</td>
</tr>
<tr>
<td>05:00</td>
<td>Adjourn</td>
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</table>
MAS Meal with a Mentor

This year at M&M 2011 in Nashville, the Microanalysis Society (MAS) is sponsoring a new educational event for students called “MAS Meal with a Mentor.” This buffet lunch, which is free to students, will be held on Monday, August 8th, from 12:00 - 1:00 PM in the Belmont Room on the Third Level of the Renaissance Nashville Hotel adjacent to the Convention Center. Seasoned MAS members will be present to share lunch with the students and to open a dialogue regarding microanalysis opportunities in academia, government, and industry. This event will be a wonderful opportunity to get acquainted and to share experiences.

“MAS Meal with a Mentor” is currently full for this year. MAS looks forward to sponsoring this educational event at future M&M meetings.

Inga H. Musselman, Chair
MAS Education Committee
imusselm@utdallas.edu

Nashville, TN circa 1919.
http://www.lib.utexas.edu/maps/historical/nashville_tn_1919.jpg
MAS Upcoming Topical Conferences

**Cathodoluminescence, CL 2011**
October 24-28, 2011
NIST, Gaithersburg, MD
co-organized by AMAS

Registration is now open!
Check the website for up-to-date information
http://www.microbeamanalysis.org/topical-conferences/cl-2011/index.htm

**Microanalytical Reference Materials**
May 15-17, 2012 • GOLDEN, CO

Want to participate in the round robin?
Contact Heather Lowers (hlowers@usgs.gov), Brian Gorman (bgorman@mines.edu), or Alan Koenig (akoenig@usgs.gov) for more information.
http://csmspace.com/events/mas/

**EBSD 2012**
June 19-21, 2012 Carnegie Mellon University
Contact Andrew Deal (deal.andrew@gmail.com), Steven Claves (steven.claves@unrpp.gov), Desmond Moser (desmond.moser@uwo.ca), or Yoosuf Picard (ypicard@cmu.edu) for more information.
In early February, 2012, the 10th Asia-Pacific Microscopy Conference (APMC 10), the 2012 International Conference on Nanoscience and Nanotechnology (ICONN 2012) and the 22nd Australian Conference on Microscopy and Microanalysis (ACMM 22) will be held in Perth, Western Australia, as a single, integrated event.

The Conference will include Short Courses, Workshops and a concurrent major Equipment Exhibition, at the Perth Convention and Exhibition Centre. The combined event will be the largest microscopy and nanotechnology-related event in Australia’s history. Over 2,000 delegates from more than 30 nations are expected to provide a unique and exciting forum.

The Conference is being conducted under the auspices of the Council of Asia-Pacific Societies for Microscopy (CAPSM), The Australian Nanotechnology Network (ANN) and the Australian Microscopy and Microanalysis Society Inc (AMMS) and the International Federation of Societies for Microscopy (IFSM).

The Conference is dedicated to the memory of Professor David Cockayne FRS.

On behalf of the Organising Committee we invite you to Perth in 2012.

Brendan Griffin & Lorenzo Faraone
The University of Western Australia

A special offer to MAS members

MAS members are extended the opportunity to register at the Australian Microbeam Analysis Society (AMAS) membership rate, given our long and close affiliation – a savings of AUD$100. MAS members should just ‘tick’ the AMMS membership box when registering.
Thanks to Our Sustaining Members

Sustaining Members consist of individuals, companies, or corporations wishing to advance the interests and objectives of the society; up to two individuals designated by the sustaining member are deemed regular members of the society.

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  The annual meeting of the Microanalysis Society in conjunction with the Microscopy Society of America

- Cathodoluminescence 2011 (NIST, Gaithersburg, MD, USA, from Oct 24-28, 2011)
  An MAS Topical Conference, co-organized by AMAS

- Microanalytical Reference Materials 2012 (Colorado School of Mines, Golden, CO, from May 15-17, 2012)
  An MAS Topical Conference

- EBSD 2012 (Carnegie Mellon University, Pittsburgh, PA, USA, from June 19-21, 2012)
  An MAS Topical Conference

- 10th Asia-Pacific Microscopy Conference, held concurrently with the ICONN 2012 and ACMM-22 (Perth Convention and Exhibition Centre, Perth, Western Australia, from February 5-9, 2012)

- Microscopy & Microanalysis 2012 (Phoenix, AZ, from Jul 29, 2012 to Aug 02, 2012)
  The annual meeting of the Microanalysis Society in conjunction with the Microscopy Society of America.